DATe European IBIS Summit
March the 14th, 2008

DATe 2008

Munich, Germany

IBIS

Mentor Graphics

SIGRITY

ZUKEN

Nokia Siemens Networks

Infineon
Never stop thinking

Agilent Technologies

DATE 08
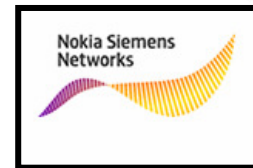
Design, Automation & Test in Europe

10-14 March, 2008 • ICM, Munich, Germany

The European Event for Electronic System Design & Test

ZUKEN

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Agenda

8:30 Refreshments & Sign In

9:00 Welcome & Introductions
   Ralf Bruening, Zuken, Germany
9:15 Driver Schedule: Pre-/De-emphasis and Frequency/Data Rate Issues
   Eckhard Lenski, Nokia Siemens Networks, Germany
9:45 IQC - IBIS Quality Checker
   Manfred Maurer* and Christian Sporrer, *Siemens AG, and **Infineon AG, Germany**
10:15 Proper IBIS Package Modeling Techniques and Usage in Ideal-PDS and SSO Simulations
   Sam Chitwood, Sigrity, USA   (Presented by Brad Brim, Sigrity, USA)

10:45 COFFEE BREAK

11:00 Macromodels of IC Buffers Allowing for Large Power Supply Fluctuations
   Flavio Canavero, Ivan Maio and Igor Stievano,
   Politecnico di Torino, Italy (Presented by Igor Stievano, Italy
11:30 BIRD104.1 - AMI Model - New IBIS Support
   Manfred Maurer, Siemens AG, Germany

12:00 LUNCH BREAK

12:30 New Interconnect Models Remove Simulation Uncertainty (CANCELLED)
   Fangyi Rao*, Chad Morgan, Vuk Borich* and Sanjeev Gupta*,**
     Agilent Technologies and **Tyc Electronics, USA (Presented by Saliou Dieye, Agilent, France)

13:15 Additional Discussion and Concluding Items

13:30 End of Meeting